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Deposition of Platinum from Bis(Acetylacetonato)Platinum(II)

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Abstract. The evaporation and deposition process of Bis(acetylacetonato)platinum(II) (Pt(acac)2) was examined in a computerized microbalance system, which allows the measuring of the mass of evaporating precursor and depositing layer simultaneously. The investigations were carried out in an argon-atmosphere and an argon/oxygen-atmosphere with pressure ranging from 250 Pa to 1000 Pa. The deposition kinetics were investigated in the temperature range between T_{dep} = 523 K and T_{dep} = 733 K. A strong dependence of the deposition rate on the pretreatment of the substrate was observed. Beginning the deposition on alumina with low deposition temperatures T_{dep} an activation energy of 204 ± 9 kJ/mol was found. On platinum precoated substrates we observed higher deposition rates and lower values for the activation energy, if the precoating was carried out at temperature T_{pre} > T_{dep}. At long deposition times with T_{dep} = const. the deposition rates on precoated substrates decreased to the values obtained without precoating at higher temperatures. This effect has not been clarified.

In argon-atmosphere platinum layers containing carbon were deposited. Increasing the deposition temperature caused increased carbon contamination. The carbon can be removed by oxidation in air after the deposition. Platinum coatings without carbon contamination were obtained by adding oxygen during the deposition process.

1. Introduction

Thin films of platinum are used in many applications, for example as electrical contacts in semiconductor devices, as coatings for high temperature crucibles, as diffusion barrier metallization or as catalysts in chemical processes.

MOCVD is a well-established technique for preparing thin films offering many advantages such as low deposition temperature, relatively simple equipment and high throwing power. For the MOCVD of platinum several volatile metalorganic compounds were investigated in the literature. One of them is Pt(acac)2, a reasonably priced, air-stable yellow powder, which is simple to handle. This is preferred in technical processes rather than other expensive, air and moisture sensitive precursor substances, for example Cyclopentadienyltrimethylplatinum [1].

First Marboe [2] described the deposition of platinum using Pt(acac)2. Further studies were made by Rand [3]. They found, that platinum layers deposited from Pt(acac)2 contain carbon, which disqualifies them for microelectronical applications. After removing the carbon by oxidation, the platinum layers deposited from Pt(acac)2 revealed no sufficient electrical conductivity. Ceramics coated with platinum from Pt(acac)2 are supposed to be used as catalysts, assuming that the codeposited carbon does not affect the catalytic activity. In this study we investigated the deposition of platinum on polycrystalline alumina in argon- and argon/oxygen-atmosphere.

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Supporting ceramic materials used for catalysts in chemical processes are of various shapes, e.g., long tubes. Therefore the deposition kinetics must be well known to optimize the throwing power of the CVD-process and prepare uniform platinum films on substrates with different geometries. So far no detailed investigation about the kinetics of evaporation and deposition of Pt(acac)₂ has been published. The evaporation and deposition process were examined in a computerized microbalance system, which allows measuring the mass of evaporating precursor and deposited layer simultaneously.

2. Experimental
A schematic diagram of the microbalance system is shown in Fig. 1. Evaporation vessel and substrate were connected with magnetic suspension balances. The balance signals were monitored by a computer, which also recorded all process readings as temperatures, total gas pressure and flow rates. All gas flow rates were adjusted by mass flow controllers.

The geometry of the evaporator shown in Fig. 2 was described earlier by Pulver et al. [4]. Pt(acac)₂ was supplied by Degussa AG. Evaporation experiments were carried out between $T_e = 413$ K and $T_e = 453$ K. Argon was used as carrier gas with a flow rate of $5$ l/h. The reactor is depicted schematically in Fig. 3. The polycrystalline alumina substrates (20 mm x 20 mm x 0.5 mm) were attached to the balance with a NiCr-wire ($\varnothing = 0.05$ mm).

The deposition temperature ranged from $T_{dep} = 523$ K to $T_{dep} = 733$ K. The investigations were carried out in argon-atmosphere and argon/oxygen-atmosphere with pressure ranging from 250 Pa to 1000 Pa. The total argon carrier gas flow was 9.5 l/h. The deposition experiments in argon/oxygen-atmosphere were made at a total gas pressure of 1000 Pa by adding oxygen through a nozzle 10 cm in front of the reactor (Fig. 1). The oxygen flow rates were 0.12 l/h and 0.3 l/h corresponding to oxygen partial pressures $p_{O_2}$ of 11 Pa and 29 Pa. The given rates of evaporation and deposition were calculated from the slope in the plot weight vs. time, which was recorded at constant conditions over a period of 30 minutes.
Platinum films were prepared in argon-atmosphere at temperatures of $T_{\text{dep}} = 653$ K, 673 K, 703 K and 723 K ($p_{\text{total}} = 1000$ Pa). Additionally a platinum film was deposited in an argon/oxygen-atmosphere at $T_{\text{dep}} = 618$ K ($p_{\text{total}} = 1000$ Pa, $p_{\text{oxygen}} = 29$ Pa). The relative carbon content was measured with WDX. The absolute carbon content was determined by measuring the weight decrease of the sample generated by oxidation of the carbon in air. The crystal structure of the films was studied with XRD. The surface morphology was examined by SEM and AFM.

3. Results and Discussion

3.1 Evaporation of Pt(acac)$_2$
In Fig.4 the evaporation rates are plotted vs. the reciprocal temperature. The activation energy for evaporation was determined to be $113 \pm 5$ kJ/mol. The evaporation rate is as expected proportional to the reciprocal total pressure [5]. By raising the gas flow from $5$ l/h to $15$ l/h the evaporation rate increased by approx. 6 %.

3.2 Deposition of Pt(acac)$_2$ in argon-atmosphere
All deposition experiments were made with a total gas flow rate of $9.5$ l/h. The dependence of the deposition rate on Pt(acac)$_2$-partial-pressure (Fig.5) was examined in the kinetics controlled regime at $T_{\text{dep}} = 658$ K (see Fig.6). The total gas pressures were 250 Pa, 500 Pa and 1000 Pa. The reaction kinetics is of first order and independent of the total pressure. For the following analysis the reduced deposition rate $i_{\text{red}} = j_{\text{dep}}/p_{\text{Pt(acac)}}$ was determined ($j_{\text{dep}}$: deposition rate, $p_{\text{Pt(acac)}}$: partial pressure of Pt(acac)$_2$). The value $i_{\text{red}}$ has the advantage, that it is independent of the partial pressure because of the linear concentration dependence (see Fig.5).

The deposition kinetics of Pt(acac)$_2$ on alumina was investigated by increasing the temperature from $T_{\text{dep}} = 653$ K to $T_{\text{dep}} = 723$ K in steps of 5 K. The temperature dependence of the deposition rate is recorded in Fig.6. Decreasing total gas pressure shifts the reduced deposition rates in the diffusion controlled regime to higher values because the reduced rate is

![Fig. 4. Evaporation rate vs. 1000/T$_{\text{ev}}$](image1)

![Fig. 5. Deposition rate vs. Pt(acac)$_2$ partial pressure (T$_{\text{dep}} = 658$ K)](image2)

![Fig. 6. Reduced deposition rate vs. reciprocal temperature](image3)
proportional to $1/p_{\text{total}}$. This relation results from the fact, that at constant mole-fraction the deposition in the diffusion controlled range is independent of the total pressure [6]. The activation energy was determined to be $204 \pm 9 \text{ kJ/mol}$, independent of the total gas pressure.

In addition deposition experiments on platinum coated substrates were made. Our investigations have shown that the deposition rate on a precoated substrate depends on the preceding deposition temperature. After substrates were precoated with platinum at $T_{\text{pre}} > T_{\text{dep}}$, the deposition rate at $T_{\text{dep}}$ was higher than the rates shown in Fig.6. To investigate this phenomenon, an alumina substrate was coated as described above (Fig.6). This means the final surface layer was deposited at $T_{\text{pre}} = 723 \text{ K}$. Afterwards the deposition temperature was decreased in steps of 15 K to $T_{\text{dep}} = 588 \text{ K}$. The reduced deposition rates are shown in Fig.7. The activation energy for the decomposition reaction of Pt(acac)$_2$ was determined to be $56 \pm 1 \text{ kJ/mol}$.

The deposition rate measured on a platinum precoated substrate at $T_{\text{dep}} = \text{const.}$ depends on the thickness of the film, which grows during the succeeding deposition process. At long deposition times the deposition rates always decreased to the values observed in Fig.6. This is shown in Fig.8. The deposition rate on a precoated substrate ($T_{\text{pre}} = 723 \text{ K}$) was measured at $T_{\text{dep}} = 653 \text{ K}$. The rates are plotted in Fig.8 vs. the deposition mass. The deposition rate remains constant until the deposited mass reaches a value of approx. 6 mg (corresponding to 0.35 µm film thickness). Then the rate decreases continuously until the deposition rate reaches the value in Fig.6.

Because of this effect an experiment with a cyclic temperature sequence causes a hysteresis loop in the plot deposition rate vs. reciprocal temperature (Fig.9): Increasing temperature from $T_{\text{dep}} = 653 \text{ K}$ to $T_{\text{dep}} = 723 \text{ K}$ in steps of 10 K (branch I in Fig.9), decreasing temperature from $T_{\text{dep}} = 723 \text{ K}$ to $T_{\text{dep}} = 573 \text{ K}$ in steps of 15 K (branch II in Fig.9), increasing temperature from $T_{\text{dep}} = 573 \text{ K}$ to $T_{\text{dep}} = 723 \text{ K}$ (branch III in Fig.9).
in steps of 15 K (branch III in Fig.9). Branch I of the plot corresponds to the normal Arrhenius plot depicted in Fig.6 and branch II corresponds to Fig.7. The horizontal part of branch III resulted from two contrary effects: The deposition rate decreases because of the reduced influence of the precoating at higher temperature (Fig.8) and at the same time the deposition rate increases because of increasing temperature. This yields a branch with almost constant deposition rates. Before reaching branch I the influence of the precoating disappears.

To prove the influence of the precoating deposition temperature on succeeding deposition rates, an experiment was carried out with an alternating temperature sequence (Fig.10). The temperature was increased in steps of 10 K from $T_{dep} = 653$ K to $T_{dep} = 723$ K, with a measurement at $T_{dep} = 653$ K after each step. Fig.10 shows, that the deposition process was influenced by precoated platinum films, if they were deposited at $T_{pre} > T_{dep}$. The deposition rates measured at a temperature of $T_{dep} = 653$ K (circles in Fig.10) increased with increasing precoating temperature. Layers deposited at lower temperatures had no significant influence on the following deposition at higher temperatures. The rates symbolized with crosses in Fig. 10 correspond to Fig.6. The last measurement at $T_{dep} = 653$ K (indicated by an arrow in Fig. 10) was recorded after a precoating at $T_{pre} = 723$ K. The observed rate corresponds to the rate depicted in Fig.7. This shows, that at the given deposition conditions and temperatures between 653 K and 723 K only deposition rates between branch I and branch II (Fig.9) can be achieved.

3.3 Deposition of Pt(acac)$_2$ in argon/oxygen-atmosphere
The deposition of platinum from Pt(acac)$_2$ was examined by adding oxygen during the deposition process to yield carbon free platinum films. Before the deposition started, we observed a delay time, in which the mass of the substrate did not increase. This phenomenon has already been described by Xue et al. [8], who called this delay "induction period". Its duration depends on the deposition temperature. Observed values for the "induction period" were 20 minutes at $T_{dep} = 598$ K or 12 minutes at $T_{dep} = 623$ K. After the "induction period" the deposition rate was constant and independent of deposition temperature (Fig.11). The lower limit for the deposition temperature was given by the temperature of the pipe connecting evaporator and deposition reactor. No activation energy could be measured.

4. Film characterization
Samples were prepared in argon-atmosphere at a total gas pressure of 1000 Pa and temperatures of $T_{dep} = 653$ K, $T_{dep} = 673$ K, $T_{dep} = 703$ K and $T_{dep} = 723$ K. Additionally one substrate coated at an oxygen partial pressure
of 29 Pa was studied. The color of the platinum layers coated in argon-atmosphere varied from silver-grey \( (T_{\text{dep}} = 653 \text{ K}) \) to black \( (T_{\text{dep}} = 723 \text{ K}) \). The films prepared in argon/oxygen-atmosphere were always silver-colored.

4.1 Film composition
The composition of the platinum films was examined with WDX-analysis. The films deposited in argon-atmosphere consisted of platinum and carbon. The relative amount of carbon increased with increasing deposition temperature. The platinum layer deposited by adding oxygen contained no carbon. Table 1 shows the count rates of the WDX-detector.

To determine the absolute amount of carbon contamination the carbon was completely removed with an oxidizing flame and the weight decrease was measured. The molar ratio between carbon and platinum was among 1.9:1 at \( T_{\text{dep}} = 653 \text{ K} \) and 2.4:1 at \( T_{\text{dep}} = 723 \text{ K} \). The large amount of carbon corresponds to the results reported by Goto et al. \[7\] or Rand \[3\].

**Table 1.** WDX analysis of platinum coated alumina substrates

<table>
<thead>
<tr>
<th>( T_{\text{dep}} ) [K]</th>
<th>atmosphere</th>
<th>intensity Pt [counts/sec]</th>
<th>intensity C [counts/sec]</th>
<th>Pt-counts/C-counts</th>
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</thead>
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<tr>
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<td>Ar</td>
<td>2209</td>
<td>300</td>
<td>7.4</td>
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<tr>
<td>673</td>
<td>Ar</td>
<td>2240</td>
<td>370</td>
<td>6.0</td>
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<tr>
<td>703</td>
<td>Ar</td>
<td>2450</td>
<td>416</td>
<td>5.9</td>
</tr>
<tr>
<td>723</td>
<td>Ar</td>
<td>2450</td>
<td>440</td>
<td>5.6</td>
</tr>
<tr>
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<td>Ar/O\textsubscript{2}</td>
<td>2987</td>
<td>23</td>
<td>130</td>
</tr>
</tbody>
</table>

4.2 Surface texture
The platinum films prepared in argon-atmosphere were studied with SEM and AFM. Fig.12 shows the surface texture by SEM observation and Fig.13 shows the surface texture by AFM observation. The grain sizes obtained by AFM-investigations are between 50 nm and 210 nm. Our SEM and AFM studies gave no indications for phenomenon of different deposition rates described above. Fig.14 presents a SEM-picture showing the porous structure of a platinum film deposited in argon/oxygen-atmosphere.

4.3 Film structure
The structure of the films prepared in argon- and argon/oxygen-atmosphere was examined with XRD (Fig.15 and Fig.16). In both cases the position and intensity of the XRD-peaks corresponded to the
structure of polycrystalline platinum [9]. The XRD patterns of substrates coated at different deposition temperatures show no remarkable differences. As Goto et al. [7] remarked, the distinguishing feature of the films deposited in different atmospheres is the full width at half maximum (FWHM) (argon-atmosphere: 2.56°, argon/oxygen-atmosphere: 0.29°). In the case of carbon contaminated films, the XRD-signals are very broad, which could be explained in principle either by small grain sizes or a distorted lattice structure. According to the grain size observed by AFM it seems reasonable that the broad signals are caused by carbon induced lattice distortion. This is confirmed by yielding sharp XRD-reflexes after burning off the carbon content. Our XRD-investigations could not clarify the phenomenon of the different deposition rates either.

5. Conclusion
The evaporation and deposition of Pt(acac)$_2$ have been investigated. The activation energy for evaporation was determined to be 113 ± 5 kJ/mol.

The decomposition reaction of Pt(acac)$_2$ was strongly influenced by the pretreatment of the substrates. In argon-atmosphere we obtained an activation energy of 204 ± 9 kJ/mol by starting deposition at low temperatures. Additionally, we yielded an activation energy of 56 ± 1 kJ/mol for deposition on a platinum covered substrate precoated at $T_{\text{pre}} = 723$ K, which demonstrates the strong influence of the substrate. Our investigations showed that only platinum layers deposited at temperatures $T_{\text{pre}} > T_{\text{dep}}$ influence the deposition process. This effect disappeared, if a precoated substrate was coated at $T_{\text{dep}} = \text{const}$. for a long deposition time. Further research is required in order to explain this effect.

In argon/oxygen-atmosphere no activation energy could be measured. The platinum layers prepared in argon had a high amount of carbon contamination. Adding oxygen during the deposition yielded carbon free platinum layers.
References